

# ZXMP10A16K 100V DPAK P-channel enhancement mode MOSFET

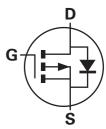
## Summary

V <sub>(BR)DSS</sub>	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A)		
-100	0.235 @ V <sub>GS</sub> = -10V	4.6		
	0.285 @ V <sub>GS</sub> = -6V	4.2		



## **Description**

This new generation trench MOSFET from Zetex features a unique structure combining the benefits of low on-resistance and fast switching, making it ideal for high efficiency power management applications.



## **Features**

- · Low on-resistance
- · Fast switching speed
- · Low threshold
- · Low gate drive
- · DPAK package

#### **Applications**

- · DC-DC converters
- Power management functions
- Disconnect switches
- Motor control

# D Pinout - top view

## **Ordering information**

Device	Reel size (inches)	Tape width (mm)	Quantity per reel	
ZXMP10A16KTC	13	16	2500	

#### **Device marking**

ZXMP 10A16

## Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain-source voltage	V <sub>DSS</sub>	-100	V
Gate-source voltage	V <sub>GS</sub>	±20	V
Continuous drain current @ V <sub>GS</sub> = 10V; T <sub>amb</sub> =25°C <sup>(b)</sup>	I <sub>D</sub>	4.6	А
@ V <sub>GS</sub> = 10V; T <sub>amb</sub> =70°C <sup>(b)</sup>		3.7	
@ V <sub>GS</sub> = 10V; T <sub>amb</sub> =25°C <sup>(a)</sup>		3	
Pulsed drain current <sup>(c)</sup>	I <sub>DM</sub>	15.4	Α
Continuous source current (body diode)(b)	I <sub>S</sub>	10.6	Α
Pulsed source current (body diode)(c)	I <sub>SM</sub>	15.4	Α
Power dissipation at T <sub>amb</sub> =25°C <sup>(a)</sup>	P <sub>D</sub>	4.24	W
Linear derating factor		34	mW/°C
Power dissipation at T <sub>amb</sub> =25°C <sup>(b)</sup>	P <sub>D</sub>	9.76	W
Linear derating factor		78	mW/°C
Power dissipation at T <sub>amb</sub> =25°C <sup>(d)</sup>	P <sub>D</sub>	2.15	W
Linear derating factor		16.8	mW/°C
Operating and storage temperature range	T <sub>j</sub> , T <sub>stg</sub>	-55 to +150	°C

#### Thermal resistance

Parameter	Symbol	Limit	Unit
Junction to ambient <sup>(a)</sup>	$R_{\Theta JA}$	29.45	°C/W
Junction to ambient <sup>(b)</sup>	$R_{\Theta JA}$	12.8	°C/W
Junction to ambient <sup>(d)</sup>	$R_{\Theta JA}$	58.1	°C/W

#### NOTES:

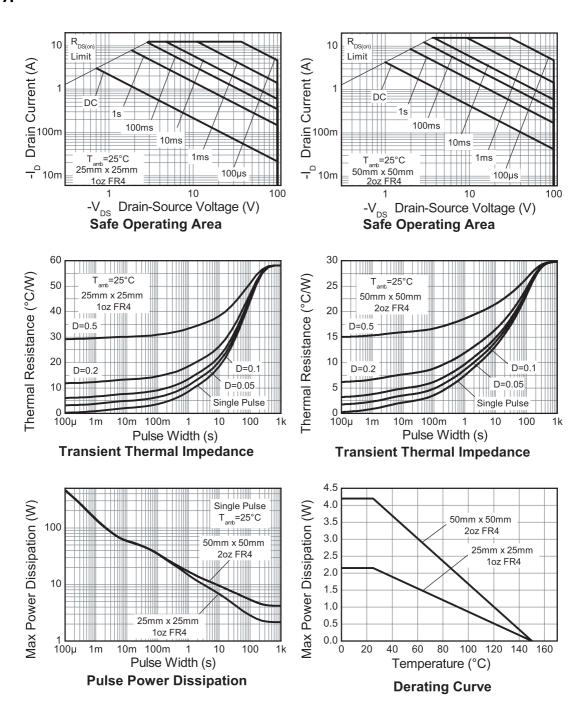
<sup>(</sup>a) For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.

<sup>(</sup>b) For a device surface mounted on FR4 PCB measured at t  $\leq$ 10 sec.

<sup>(</sup>c) Repetitive rating 50mm x 50mm x 1.6mm FR4 PCB, D=0.02 pulse width=300 $\mu$ s - pulse width limited by maximum junction temperature.

<sup>(</sup>d) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

## **Typical characteristics**



## Electrical characteristics (at T<sub>amb</sub> = 25°C unless otherwise stated)

Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions	
Static							
Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	-100			V	I <sub>D</sub> = 250μA, V <sub>GS</sub> =0V	
Zero gate voltage drain current	I <sub>DSS</sub>			-1	μΑ	V <sub>DS</sub> = -100V, V <sub>GS</sub> =0V	
Gate-body leakage	I <sub>GSS</sub>			100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	
Gate-source threshold voltage	V <sub>GS(th)</sub>	-2.0		-4.0	V	$I_{D}$ = -250 $\mu$ A, $V_{DS}$ = $V_{GS}$	
Static drain-source on-state	R <sub>DS(on)</sub>			0.235	W	V <sub>GS</sub> = -10V, I <sub>D</sub> = -2.1A	
resistance (*)				0.285		V <sub>GS</sub> = -6V, I <sub>D</sub> = -1.9A	
Forward transconductance(*) (‡)	9 <sub>fs</sub>		4.7		S	V <sub>DS</sub> = -15V, I <sub>D</sub> = -2.1A	
Dynamic <sup>(‡)</sup>							
Input capacitance	C <sub>iss</sub>		717		pF	V <sub>DS</sub> = -50V, V <sub>GS</sub> =0V	
Output capacitance	C <sub>oss</sub>		55.3		pF	f=1MHz	
Reverse transfer capacitance	C <sub>rss</sub>		46.4		pF		
Switching (†) (‡)							
Turn-on-delay time	t <sub>d(on)</sub>		4.3		ns	V <sub>DD</sub> = -50V, I <sub>D</sub> = -1A	
Rise time	t <sub>r</sub>		5.2		ns	$R_G=6.0\Omega$ , $V_{GS}=-10V$	
Turn-off delay time	t <sub>d(off)</sub>		20		ns		
Fall time	t <sub>f</sub>		12.1		ns		
Total gate charge	$Q_g$		16.5		nC	V <sub>DS</sub> = -50V, V <sub>GS</sub> = -10V	
Gate-source charge	Q <sub>gs</sub>		2.47		nC	I <sub>D</sub> = -2.1A	
Gate drain charge	$Q_{gd}$		5.36		nC		
Source-drain diode							
Diode forward voltage <sup>(*)</sup>	$V_{SD}$		-0.85	-0.95	V	T <sub>j</sub> =25°C, I <sub>S</sub> = -3.35A, V <sub>GS</sub> =0V	
Reverse recovery time <sup>(‡)</sup>	t <sub>rr</sub>		43.3		ns	T <sub>j</sub> =25°C, I <sub>S</sub> = -2.4A,	
Reverse recovery charge <sup>(‡)</sup>	O <sub>rr</sub>		76.5		nC	di/dt=100A/μs	

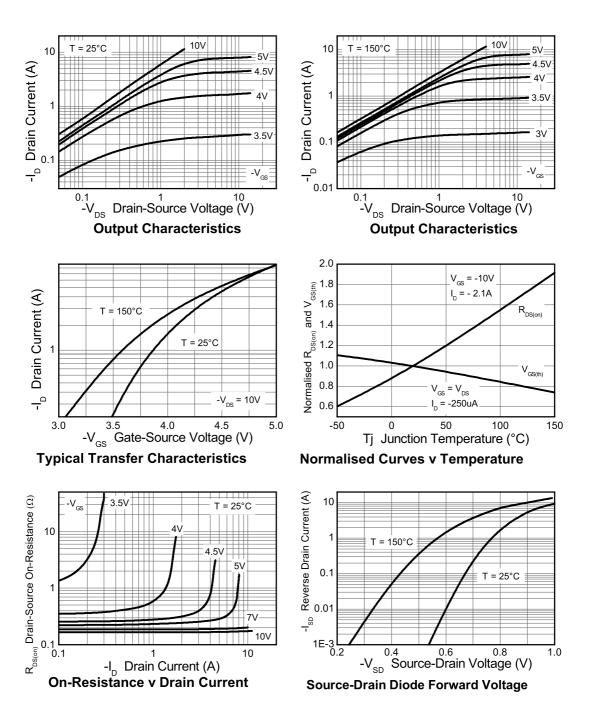
#### NOTES:

<sup>(\*)</sup> Measured under pulsed conditions. Pulse width  $\leq$ 300 $\mu$ s; duty cycle  $\leq$ 2%.

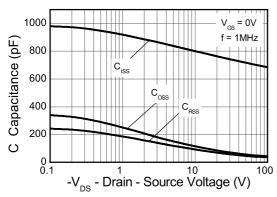
<sup>(†)</sup> Switching characteristics are independent of operating junction temperature.

<sup>(‡)</sup> For design aid only, not subject to production testing.

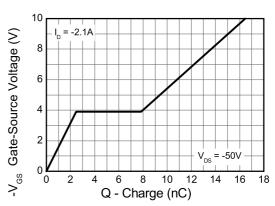
## **Typical characteristics**



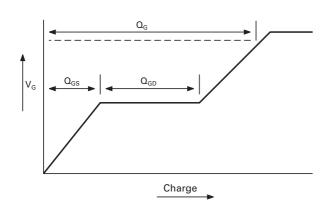
## **Typical characteristics**



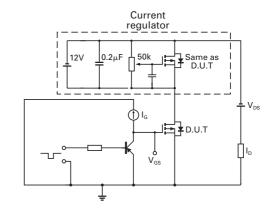
Capacitance v Drain-Source Voltage



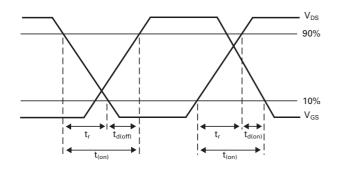
Gate-Source Voltage v Gate Charge



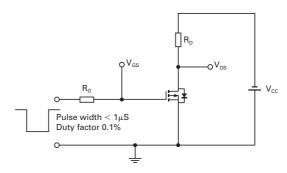
Basic gate charge waveform



Gate charge test circuit



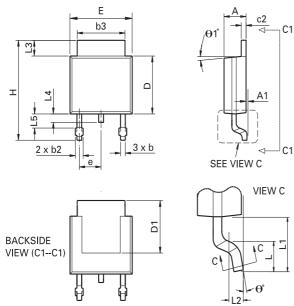
**Switching time waveforms** 



Switching time test circuit

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### Package details - DPAK



DIM	Inc	hes	Millin	Millimeters		Inches		Millin	neters	
	Min	Max	Min	Max		Min	Max	Min	Max	
Α	0.086	0.094	2.18	2.39	е	0.090 BSC		e 0.090 BSC 2.29 BSC		BSC
A1	-	0.005	-	0.127	Н	0.370	0.410	9.40	10.41	
b	0.020	0.035	0.508	0.89	L	0.055	0.070	1.40	1.78	
b2	0.030	0.045	0.762	1.14	L1	0.108 REF		2.74 REF		
b3	0.205	0.215	5.21	5.46	L2	0.020 BSC		0.508 BSC		
С	0.018	0.024	0.457	0.61	L3	0.035	0.065	0.89	1.65	
c2	0.018	0.023	0.457	0.584	L4	0.025	0.040	0.635	1.016	
D	0.213	0.245	5.41	6.22	L5	0.045	0.060	1.14	1.52	
D1	0.205	-	5.21	-	θ1°	0°	10°	0°	10°	
Е	0.250	0.265	6.35	6.73	$\theta_{o}$	0°	15°	0°	15°	
E1	0.170	-	4.32	-	=	-	-	-	-	

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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